

N-Channel Enhancement Mode Power MOSFET

Description

The MS5N50 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220 package is universally preferred for all commercial-industrial applications

Features

- BVDSS=550V typically @ Tj=150°C
- Low On Resistance
- · Simple Drive Requirement
- Low Gate Charge
- · Fast Switching Characteristic
- · RoHS compliant package

Application

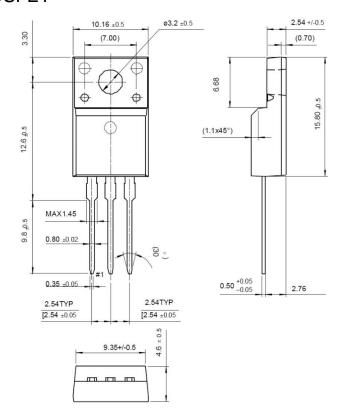
- Ballast
- Inverter

Packing & Order Information

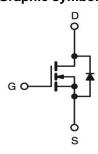
50/Tube; 1,000/Box



RoHS COMPLIANT



Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings						
Symbol	Parameter	Value	Unit			
V_{DSS}	Drain to Source Voltage	500	V			
V_{G}	Gate to Source Voltage	±30	V			
I_	Continuous Drain Current (TC=25°C)	4.5	Α			
I _D	Continuous Drain Current (TC=100°C)	3.0	^			
I_{DM}	Drain Current Pulsed	18	A			
E _{AS}	Single Pulsed Avalanche Energy	271	mJ			
E _{AR}	Repetitive Avalanche Energy	7.3	mJ			
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns			

Drain current limited by maximum junction temperature



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Absolute Maximum Ratings							
Symbol	Parameter	Value	Unit				
T _L	TL Maximum Temperature for Soldering @ Lead at 0.125 in(0.318mm) from case for 10 seconds	300	°C				
T _{PKG}	TPKG Maximum Temperature for Soldering @ Package Body for 10 seconds	260	°C				
	Total Power Dissipation(@TC = 25 °C) 100 W	73	W				
P_D	Derating Factor above 25 °C	0.57	W/°C				
T _{STG}	Operating Junction Temperature	-55 to +150	°C				
T _J	Storage Temperature	150	°C				

Note:

- 1. TJ=+25°C to +150°C.
- 2. Repetitive rating; pulse width limited by maximum junction temperature.
- 3. ISD=4.5A, $dI/dt<100A/\mu s$, VDD<BVDSS, TJ=+150°C.
- 4. IAS=4.5A, VDD=50V, L=15mH, RG=25 Ω , starting TJ=+25 $^{\circ}$ C.

Thermal Characteristics							
Symbol	Parameter		Units				
	raiailletei	Min.	Тур.	Max.	Offics		
$R_{ heta JC}$	Thermal Resistance,Junction-to-Case			1.47	°C/W		
$R_{\theta JA}$	Thermal Resistance,Junction-to-Ambient			62.5	°C/W		

Static Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
D\/		$V_{GS} = 0 \text{ V}, I_{D} = 250 \text{ uA}$	500			V	
BV _{DSS}	Drain-Source Breakdown Voltage	Tj = 150°C		550		V	
ΔBV_{DSS} $/\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$, Referenced to 25°C		0.6		V/°C	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{ uA}$	2.0		4.0	V	
I _{DSS}	Drain-Source Leakage Current	V _{DS} = 500 V , V _{GS} = 0 V V _{DS} = 400 V , T _C = 125°C			25 250	uA nA	
I _{GSS}	Gate-Source Leakage,Forward	$V_{GS} = \pm 30$			±100	nA	
R _{DS(ON)}	Static Drain-Source On-state Resis-tance	$V_{GS} = -10 \text{ V}$, $I_D = 2.7 \text{ A}$			1.5	Ω	

Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
Q_g	Total Gate Charge	V _{DD} = 250 V,		11		nC	
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V,		3		nC	
Q_{gd}	Gate-Drain Charge (Miller Charge)	I _D = 4.5 A		5		nC	



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Dynamic	Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units		
$t_{d(on)}$	Turn-On Delay Time			13		ns		
t _r	Rise Time	$V_{DD} = 250 \text{ V}, I_D = 4.5 \text{ A},$		22		ns		
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V},$ $R_{G} = 25 \Omega$		28		ns		
tf	Fall Time	11.G - 20 12		20		ns		
C _{ISS}	Input Capacitance			460		pF		
Coss	Output Capacitance	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		60		pF		
C _{RSS}	Reverse Transfer	f = 1MHz		5		pF		
	Capacitance					PF		

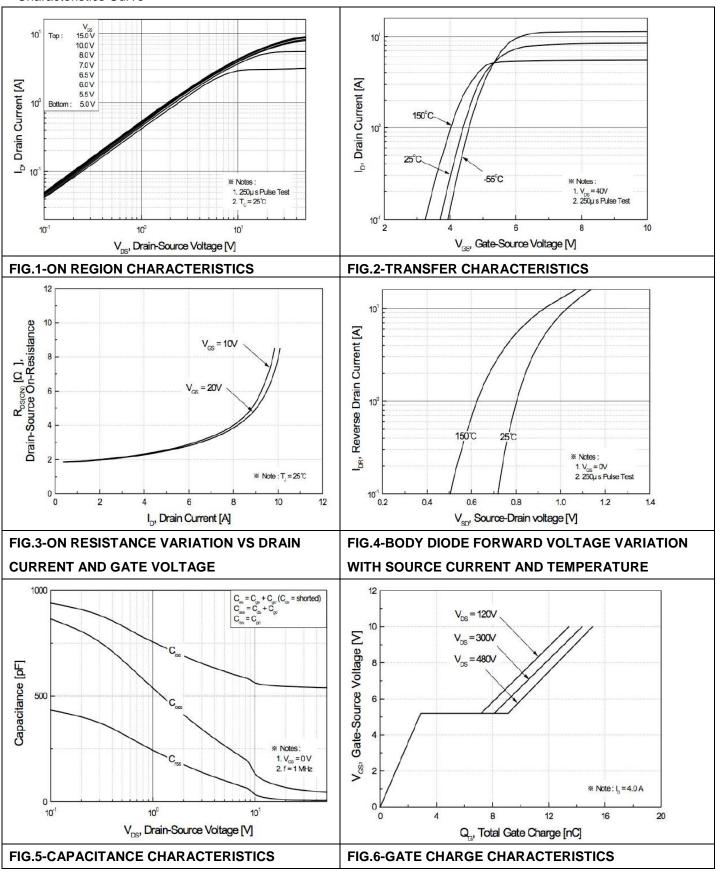
Source-Drain Diode							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
Is		$I_{S} = 4.5 \text{ A}, V_{GS} = 0 \text{V}$			1.5	V	
I _{SM}		$V_D=V_G=0$,			4.5	Α	
V _{SD}		$V_D = V_G = 0,$ $V_S = 1.3 \text{ V}$			18	А	
t _{rr}		$V_{GS} = 0$, IF = 4.5 A,		230		ns	
Q _{rr}		dI/dt = 100A/us		1.6		uC	

^{*}Pulse Test : Pulse Width ≤300µs, Duty Cycle≤2%



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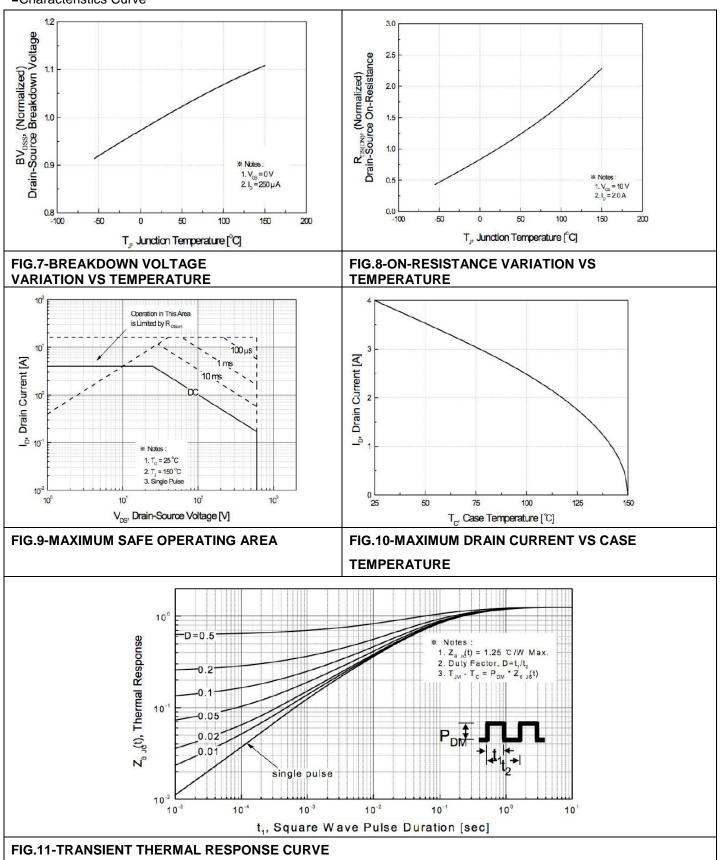
■Characteristics Curve





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■Characteristics Curve





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